

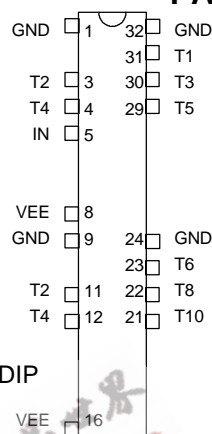
5-TAP, ECL-INTERFACED FIXED DELAY LINE (SERIES DDU12H)



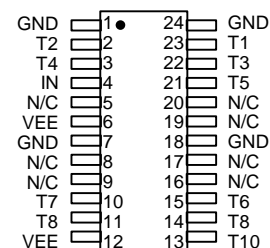
FEATURES

- Ten equally spaced outputs
- Fits in 300 mil 32-pin DIP socket
- Input & outputs fully 10KH-ECL interfaced & buffered

PACKAGES



DDU12H-xx DIP
DDU12H-xxM Military DIP



DDU12H-xxC3 SMD
DDU12H-xxMC3 Mil SMD

FUNCTIONAL DESCRIPTION

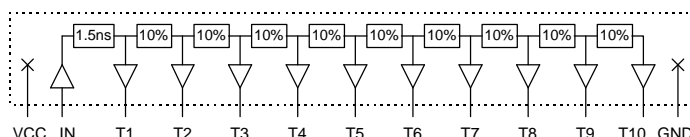
The DDU12H-series device is a 10-tap digitally buffered delay line. The signal input (IN) is reproduced at the outputs (T1-T10), shifted in time by an amount determined by the device dash number (See Table). For dash numbers less than 20, the total delay of the line is measured from T1 to T10. The nominal tap-to-tap delay increment is given by one-ninth of the total delay, and the inherent delay from IN to T1 is nominally 1.5ns. For dash numbers greater than or equal to 20, the total delay of the line is measured from IN to T10. The nominal tap-to-tap delay increment is given by one-tenth of this number.

PIN DESCRIPTIONS

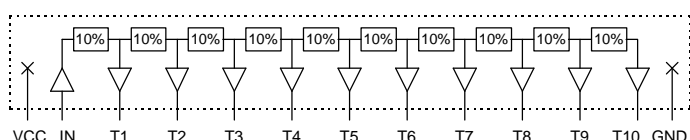
IN Signal Input
T1-T10 Tap Outputs
VEE -5 Volts
GND Ground

SERIES SPECIFICATIONS

- **Minimum input pulse width:** 10% of total delay
- **Output rise time:** 2ns typical
- **Supply voltage:** -5VDC \pm 5%
- **Power dissipation:** 400mw typical (no load)
- **Operating temperature:** -30° to 85° C
- **Temp. coefficient of total delay:** 100 PPM/°C



Functional diagram for dash numbers < 20



Functional diagram for dash numbers \geq 20

DASH NUMBER SPECIFICATIONS

| Part Number | Total Delay (ns) | Delay Per Tap (ns) |
|-------------|------------------|--------------------|
| DDU12H-10 | 9 \pm 1.0 * | 1.0 \pm 0.3 |
| DDU12H-20 | 20 \pm 2.0 | 2.0 \pm 0.4 |
| DDU12H-25 | 25 \pm 2.0 | 2.5 \pm 0.4 |
| DDU12H-40 | 40 \pm 2.0 | 4.0 \pm 0.5 |
| DDU12H-50 | 50 \pm 2.5 | 5.0 \pm 1.0 |
| DDU12H-75 | 75 \pm 4.0 | 7.5 \pm 1.5 |
| DDU12H-100 | 100 \pm 5.0 | 10.0 \pm 2.0 |
| DDU12H-150 | 150 \pm 7.5 | 15.0 \pm 2.0 |
| DDU12H-200 | 200 \pm 10.0 | 20.0 \pm 2.0 |
| DDU12H-250 | 250 \pm 12.5 | 25.0 \pm 2.0 |
| DDU12H-300 | 300 \pm 15.0 | 30.0 \pm 2.0 |
| DDU12H-400 | 400 \pm 20.0 | 40.0 \pm 2.0 |
| DDU12H-500 | 500 \pm 25.0 | 50.0 \pm 2.5 |
| DDU12H-750 | 750 \pm 37.5 | 75.0 \pm 4.0 |
| DDU12H-1000 | 1000 \pm 50.0 | 100.0 \pm 5.0 |
| DDU12H-1500 | 1500 \pm 75.0 | 150.0 \pm 7.0 |

* Total delay is referenced to first tap output
Input to first tap = 1.5ns \pm 1ns

NOTE: Any dash number between 10 and 1500 not shown is also available.

APPLICATION NOTES

HIGH FREQUENCY RESPONSE

The DDU12H tolerances are guaranteed for input pulse widths and periods greater than those specified in the test conditions. Although the device will function properly for pulse widths as small as 10% of the total delay and periods as small as 20% of the total delay (for a symmetric input), the delays may deviate from their values at low frequency. However, for a given input condition, the deviation will be repeatable from pulse to pulse. Contact technical support at Data

Delay Devices if your application requires device testing at a specific input condition.

POWER SUPPLY BYPASSING

The DDU12H relies on a stable power supply to produce repeatable delays within the stated tolerances. A 0.1 μ f capacitor from VEE to GND, located as close as possible to the VEE pin, is recommended. A wide VEE trace and a clean ground plane should be used.

DEVICE SPECIFICATIONS

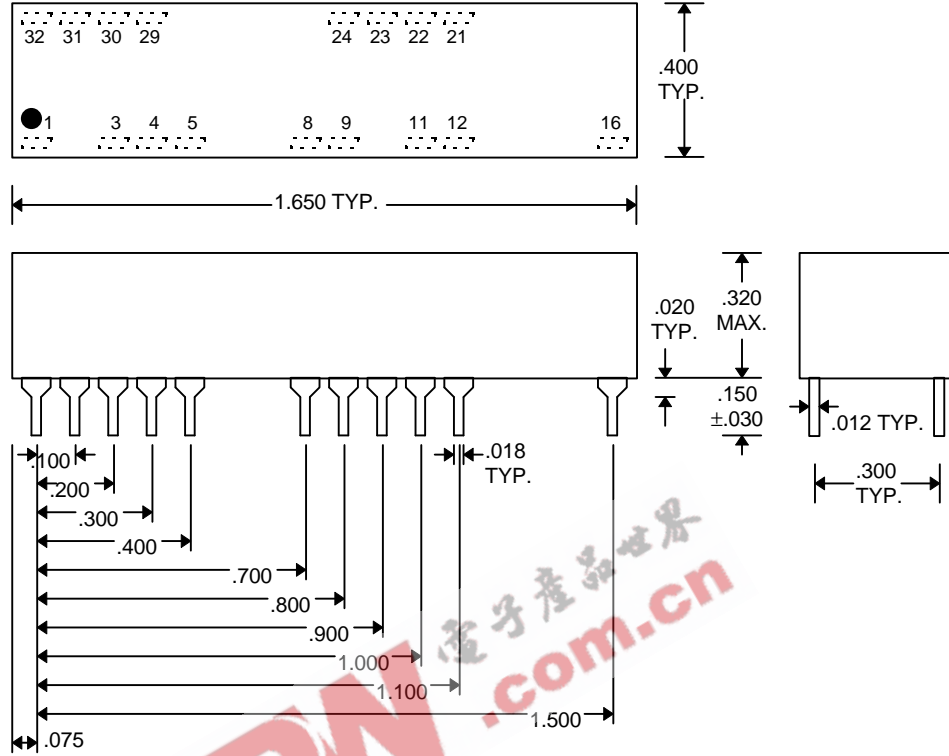
TABLE 1: ABSOLUTE MAXIMUM RATINGS

| PARAMETER | SYMBOL | MIN | MAX | UNITS | NOTES |
|---------------------|-------------------|-----------------------|-----|-------|--------|
| DC Supply Voltage | V _{EE} | -7.0 | 0.3 | V | |
| Input Pin Voltage | V _{IN} | V _{EE} - 0.3 | 0.3 | V | |
| Storage Temperature | T _{STRG} | -55 | 150 | C | |
| Lead Temperature | T _{LEAD} | | 300 | C | 10 sec |

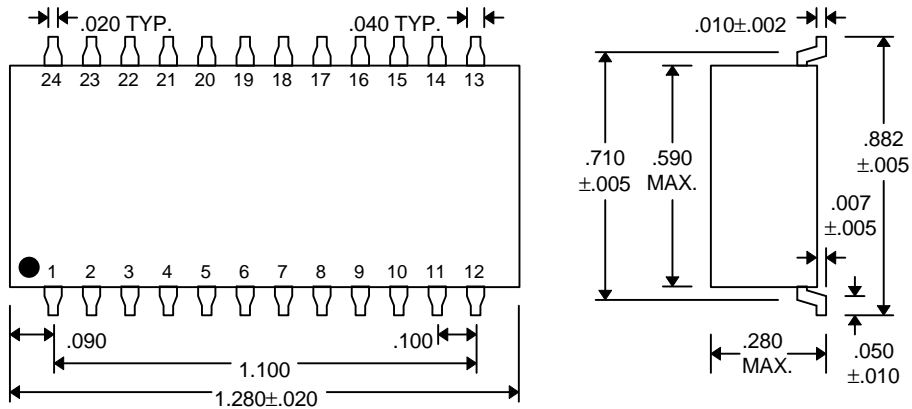
TABLE 2: DC ELECTRICAL CHARACTERISTICS
(0C to 75C)

| PARAMETER | SYMBOL | MIN | TYP | MAX | UNITS | NOTES |
|---------------------------|-----------------|--------|-----|--------|---------|---|
| High Level Output Voltage | V _{OH} | -1.020 | | -0.735 | V | V _{IH} = MAX, 50 Ω to -2V |
| Low Level Output Voltage | V _{OL} | -1.950 | | -1.600 | V | V _{IL} = MIN, 50 Ω to -2V |
| High Level Input Voltage | V _{IH} | | | -1.070 | V | |
| Low Level Input Voltage | V _{IL} | -1.480 | | | V | |
| High Level Input Current | I _{IH} | | | 475 | μ A | V _{IH} = MAX |
| Low Level Input Current | I _{IL} | 0.5 | | | μ A | V _{IL} = MIN |

PACKAGE DIMENSIONS



DDU12H-xx (Commercial DIP)
DDU12H-xxM (Military DIP)



DDU12H-xxC4 (Commercial SMD)
DDU12H-xxMC4 (Military SMD)

DELAY LINE AUTOMATED TESTING

TEST CONDITIONS

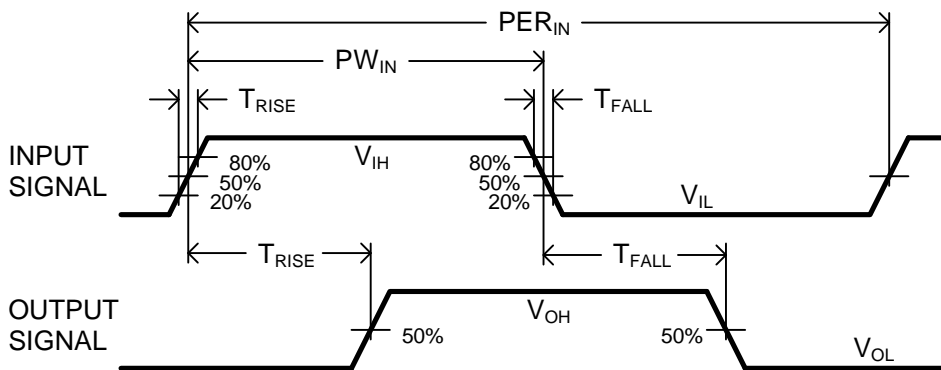
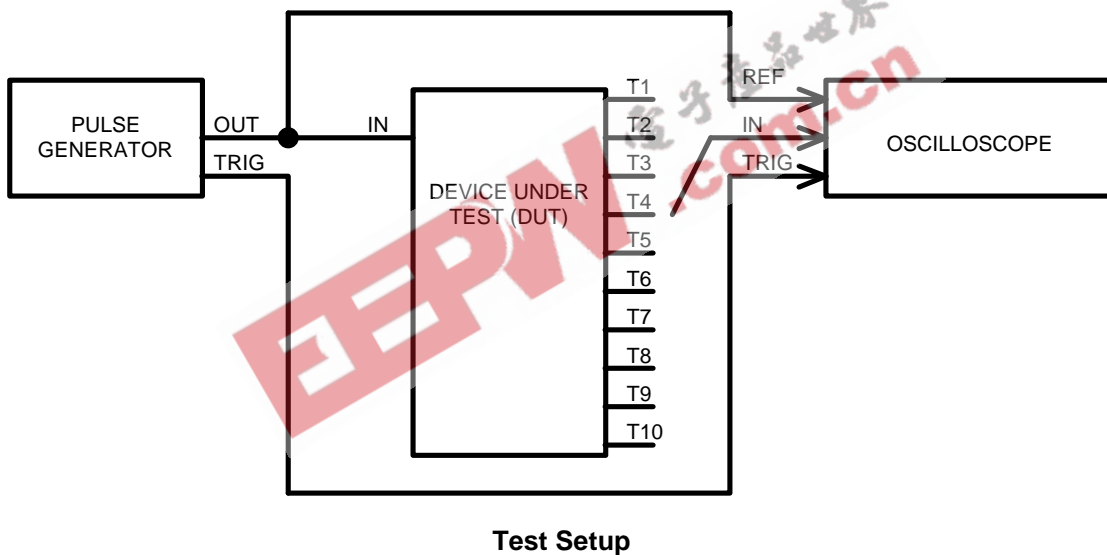
INPUT:

Ambient Temperature: $25^{\circ}\text{C} \pm 3^{\circ}\text{C}$
Supply Voltage (Vcc): $-5.0\text{V} \pm 0.1\text{V}$
Input Pulse: Standard 10KH ECL levels
Source Impedance: 50Ω Max.
Rise/Fall Time: 2.0 ns Max. (measured between 20% and 80%)
Pulse Width: $PW_{IN} = 1.5 \times \text{Total Delay}$
Period: $PER_{IN} = 10 \times \text{Total Delay}$

OUTPUT:

Load: 50Ω to -2V
C_{load}: $5\text{pf} \pm 10\%$
Threshold: $(V_{OH} + V_{OL}) / 2$
 (Rising & Falling)

NOTE: The above conditions are for test only and do not in any way restrict the operation of the device.



Timing Diagram For Testing